

CRYOEM 001 : TOOLS OF THE TRADE - MICROSCOPES AND DETECTORS

NCCAT Embedded Training — Master Class series

September 30 - October 5, 2020

NATIONAL CENTER FOR
CRYOEM ACCESS & TRAINING



New York Structural
Biology Center

SIMONS ELECTRON
MICROSCOPY CENTER



CRYOEM 001 : SINGLE PARTICLE MASTERCLASS

Introduction to cryoEM: SPA

Building a cryoEM toolkit

EM compatible samples

EM support films and grids

Sample preparation

Tools of the trade:

microscopes and detectors

Microscope operations

Data collection strategies

Data assessment & QC

Data processing:

cryoEM IT infrastructure

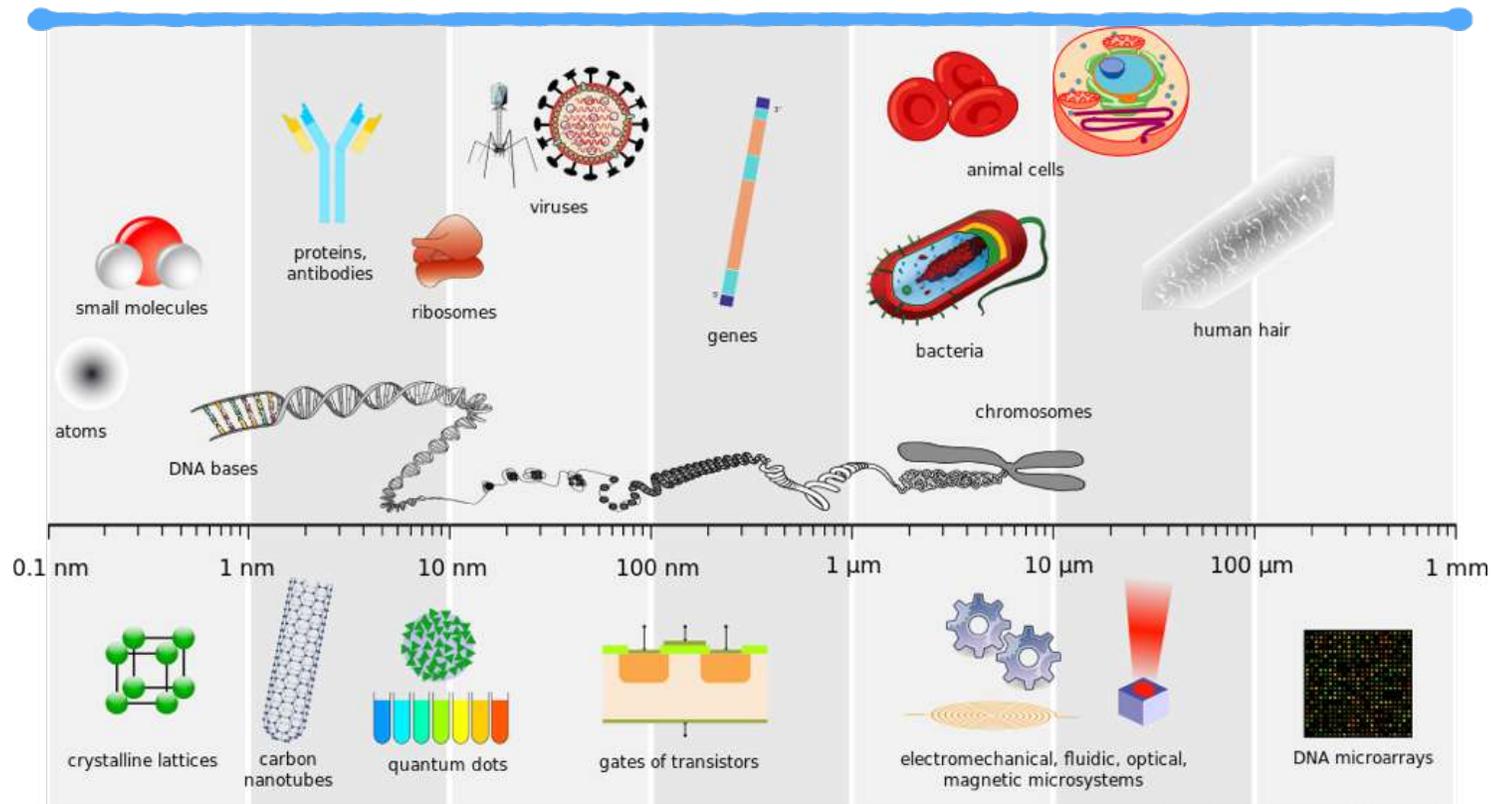
On-the-fly feedback

3D Reconstruction

Visualization and validation

CRYOEM: SCALE WITHIN BIOLOGY

Electron Microscopy



<https://en.wikipedia.org/wiki/Nanoscale>

X-ray

NMR

AFM

Light microscopy

Naked eye

WHAT BROUGHT ABOUT THE RESOLUTION REVOLUTION

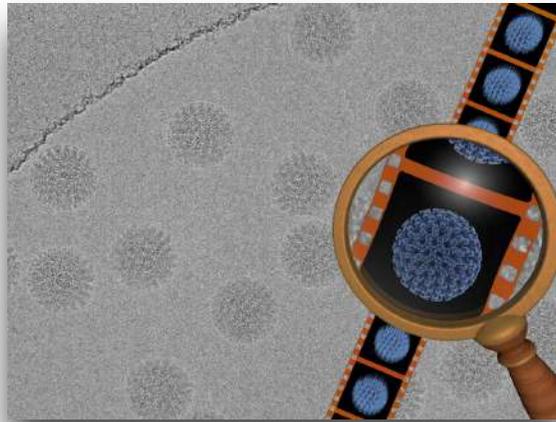
(~2012-2014)

Hardware

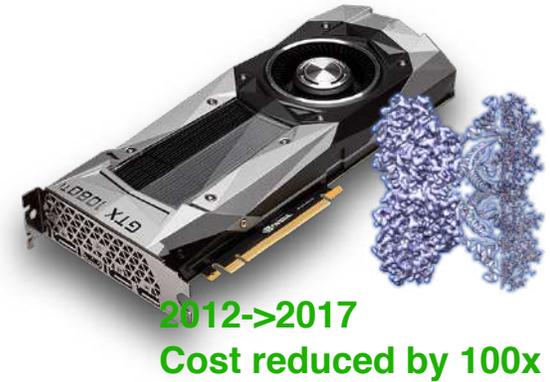
Microscopes



Direct Detectors



Computers

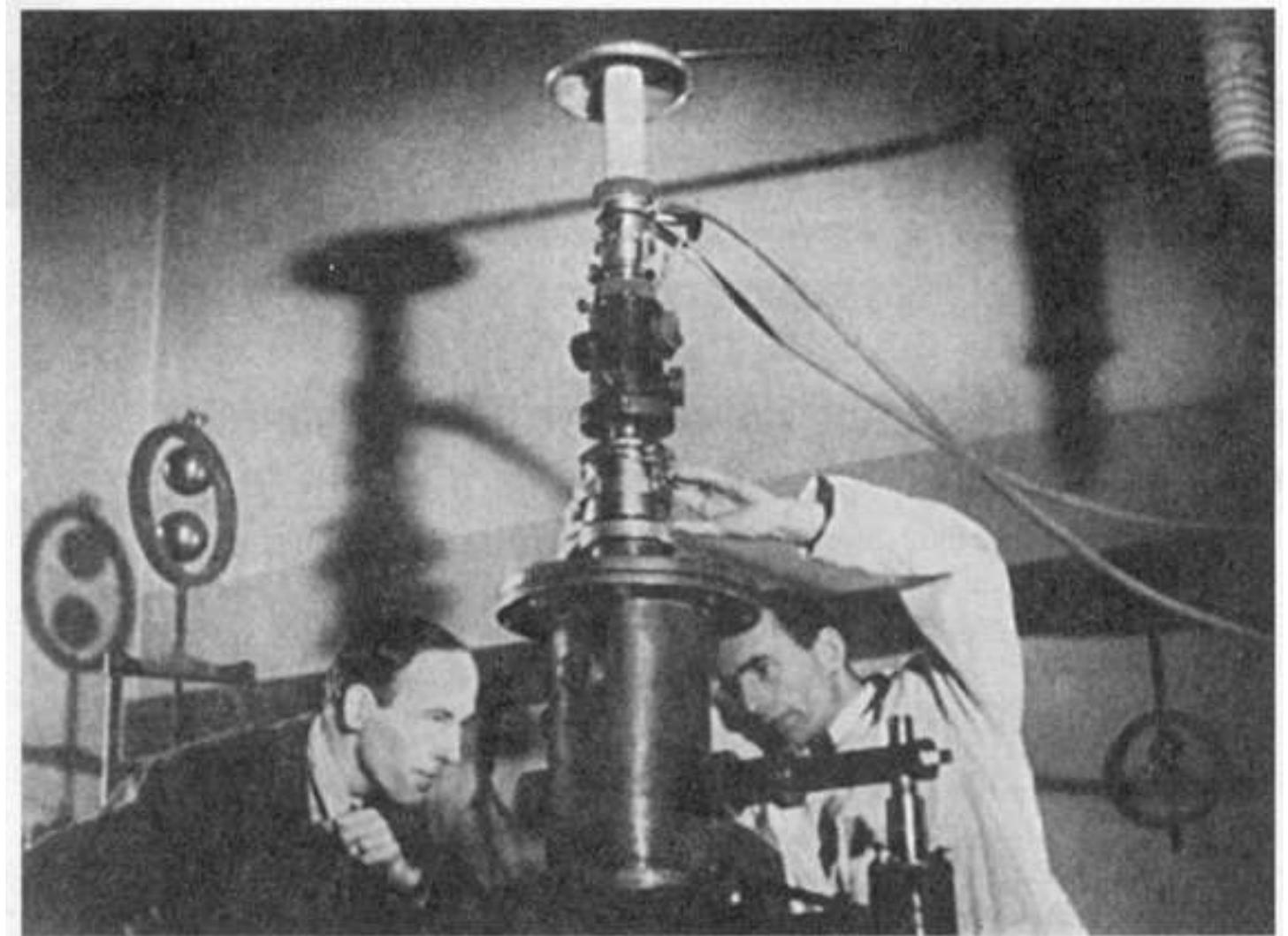


2012->2017
Cost reduced by 100x

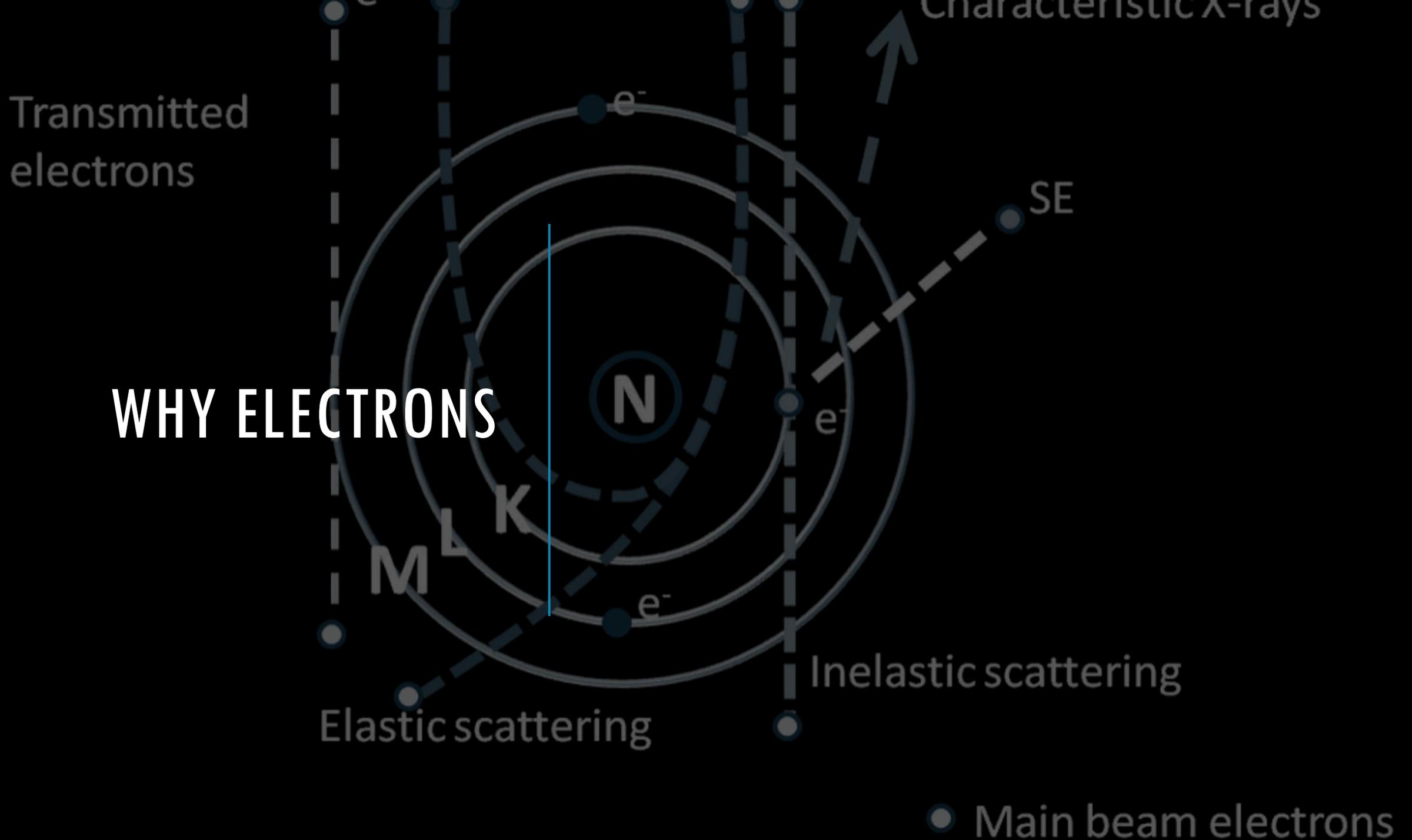
THE ELECTRON MICROSCOPE

Ruska and Knoll in Berlin in the
early 1930s

-Wikipedia



WHY ELECTRONS



WHY ELECTRONS

Pros

Small wavelength

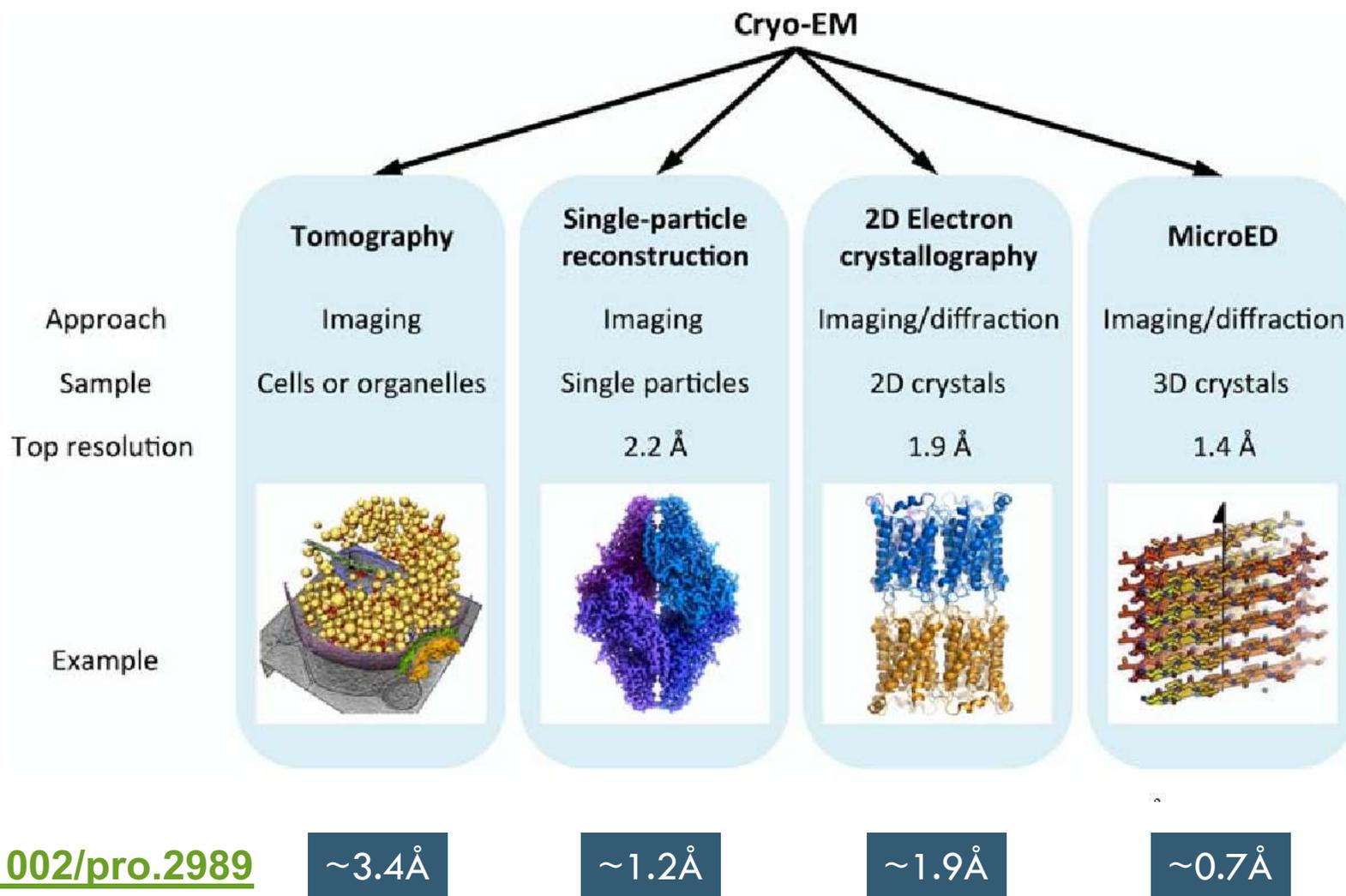
Can be focused

Cons

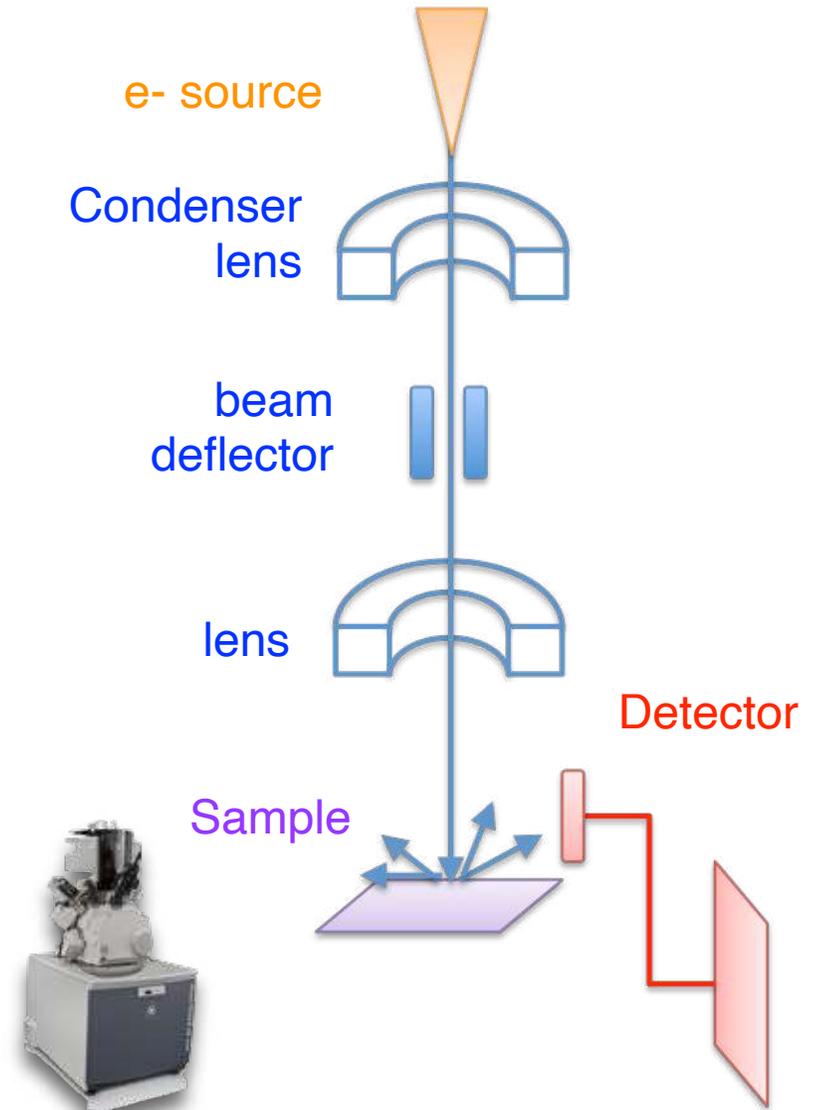
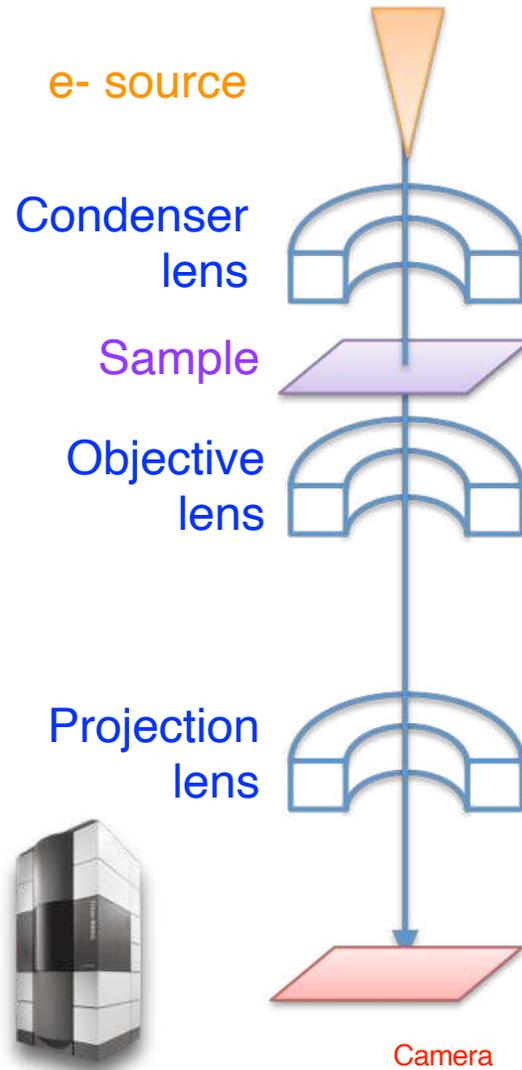
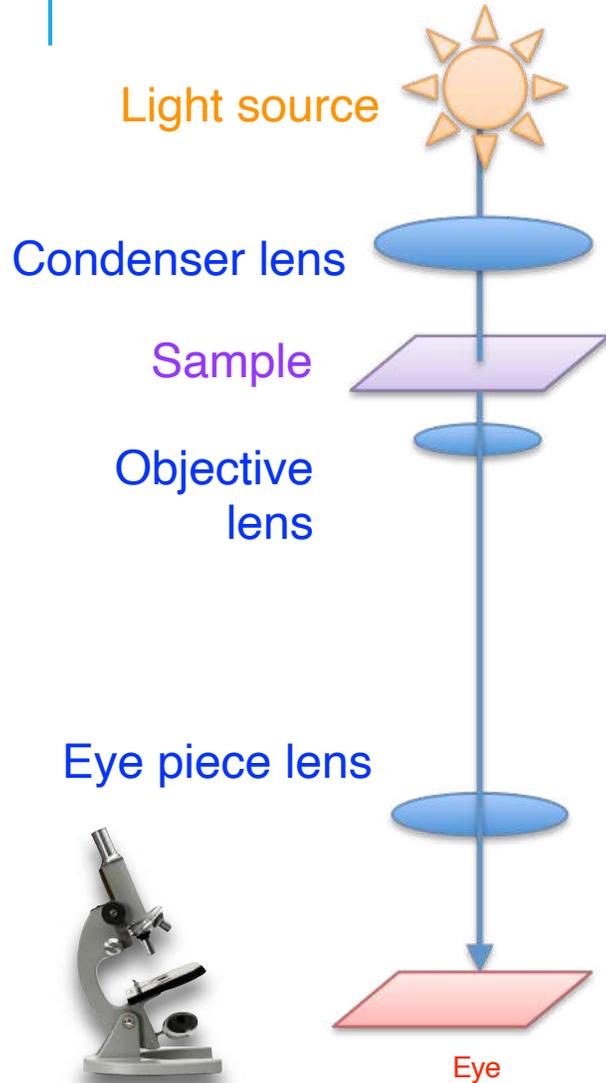
Damages sample
worse with faster electrons

Poor penetration
better with faster electrons

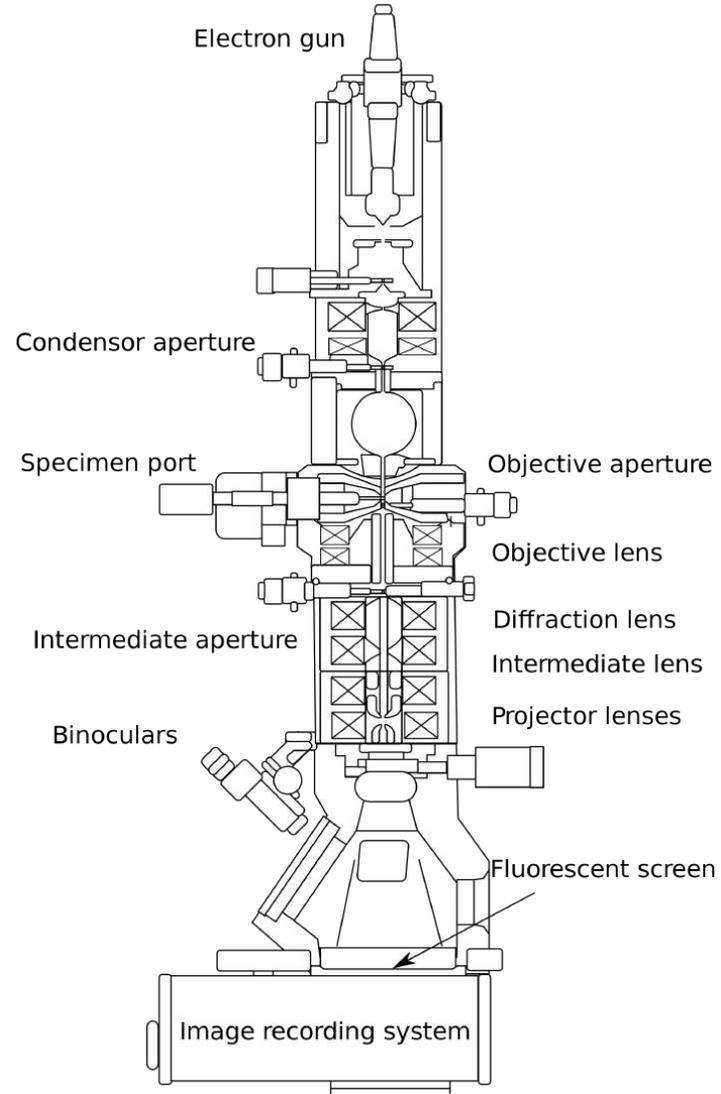
CRYOEM MODALITIES AND TOOLS



CRYOEM TOOLS



MAIN PARTS OF AN EM



Electron sources



Vacuum systems



Lenses

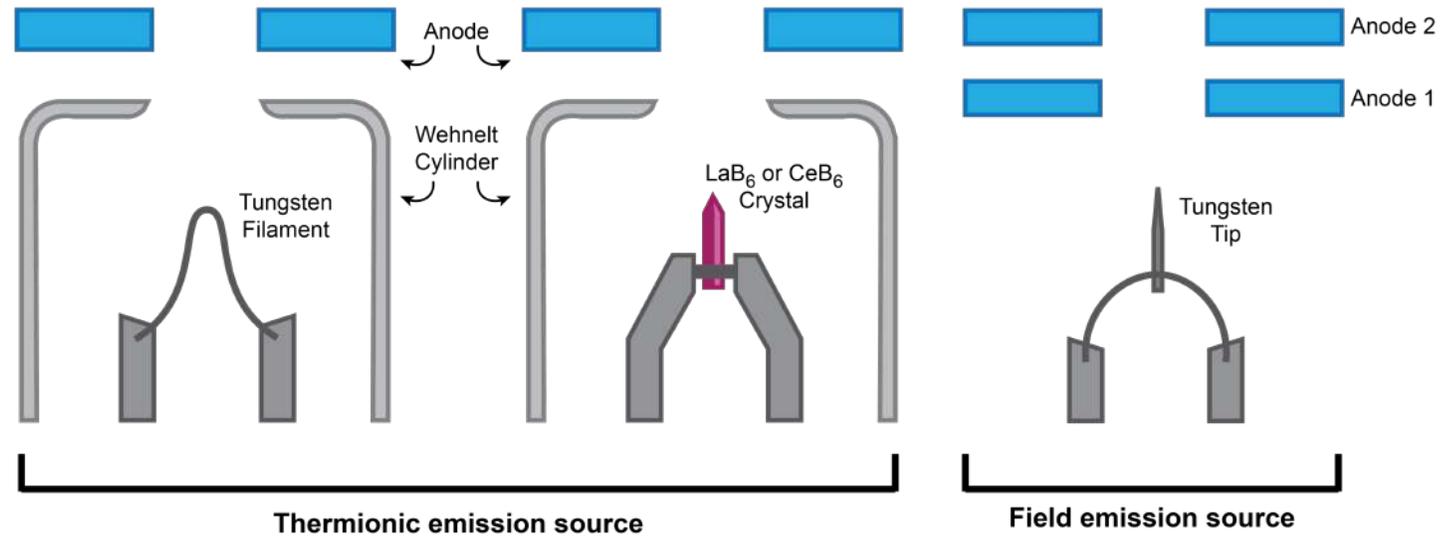


Detectors



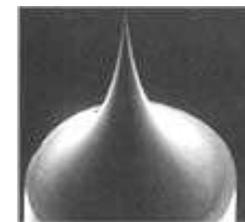
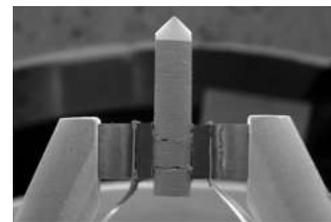
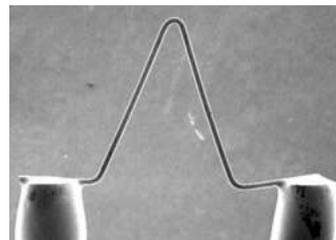
ELECTRON SOURCES

What are the 3 main kinds of electron sources?



www.thermofisher.com

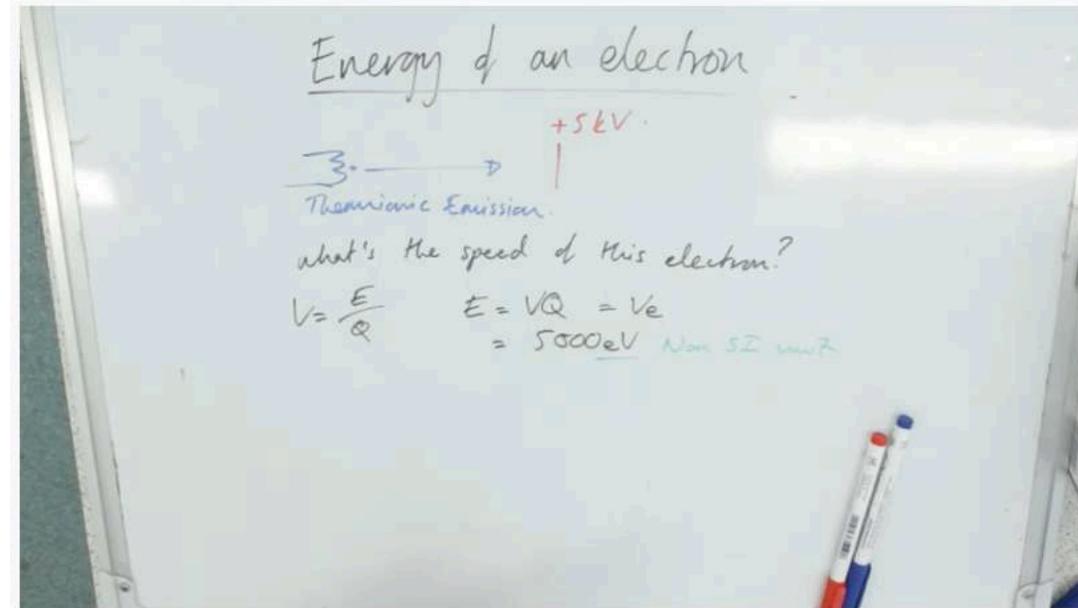
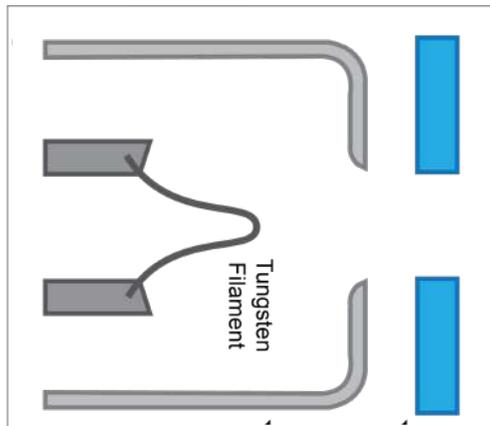
nanoscience.com





ELECTRON SOURCES

How fast are the electrons moving?

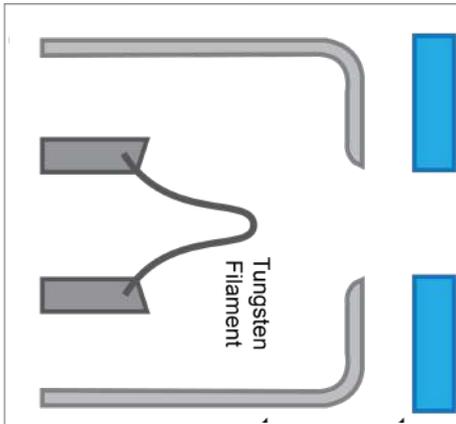


<https://www.youtube.com/watch?v=tYCET6vYdYk>



ELECTRON SOURCES

How fast are the electrons moving?



Energy of an electron

$+5kV$

Thermionic Emission

what's the speed of this electron?

$$V = \frac{E}{Q} \quad E = VQ = Ve$$
$$= 5000eV \quad \text{Non SI units}$$
$$E = 5000 \times 1.6 \times 10^{-19} = 8 \times 10^{-16} J$$
$$E_k = \frac{1}{2}mv^2 \quad m_e = 9.11 \times 10^{-31} kg$$
$$8 \times 10^{-16} = \frac{1}{2}mv^2$$

Energy of an electron

$+5kV$

Thermionic Emission

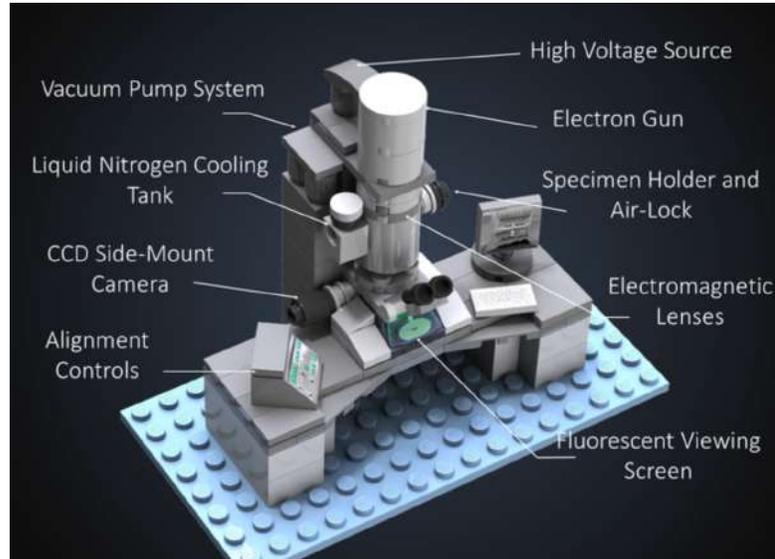
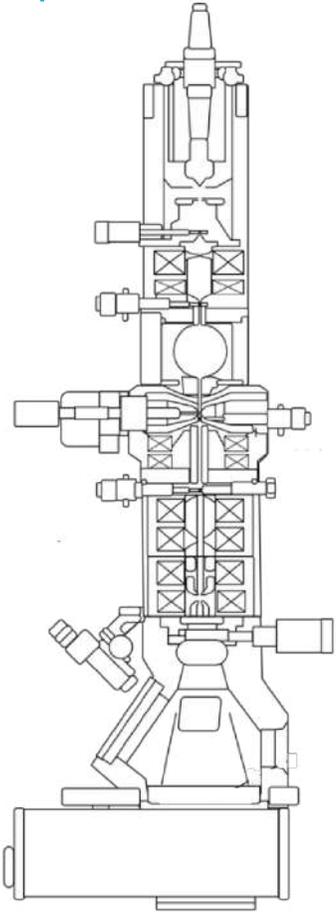
what's the speed of this electron?

$$E = VQ = Ve$$
$$= 5000eV \quad \text{Non SI units}$$
$$\times 1.6 \times 10^{-19} = 8 \times 10^{-16} J$$
$$8 \times 10^{-16} = \frac{1}{2}mv^2 \quad m_e = 9.11 \times 10^{-31} kg$$
$$\frac{2 \times 8 \times 10^{-16}}{9.11 \times 10^{-31}} = 17400000 = 1.74 \times 10^7 m/s$$

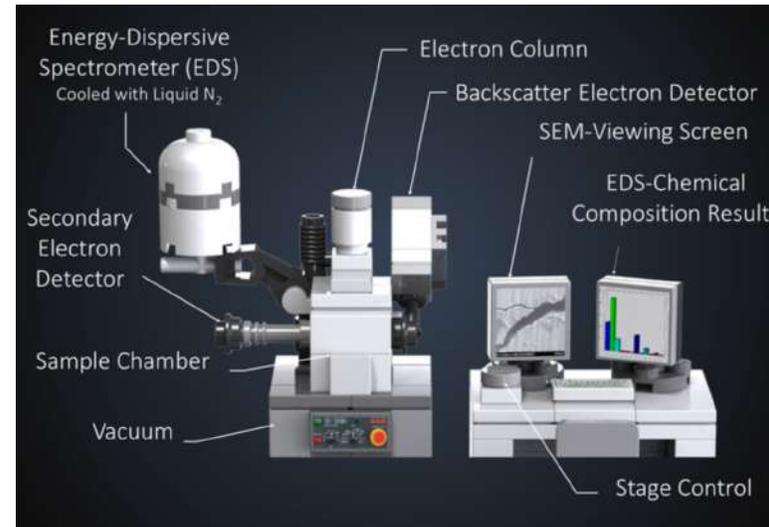
<https://www.youtube.com/watch?v=tYCET6vYdYk>



ELECTRON SOURCES & TYPES OF EMS

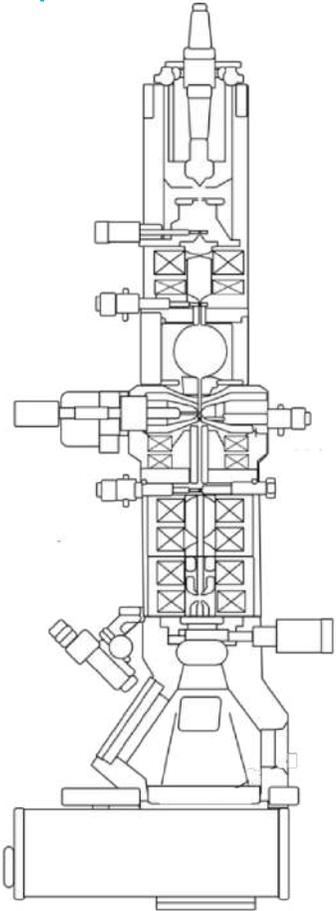


<https://ideas.lego.com/projects/102281>





ELECTRON SOURCES & TYPES OF EMS



80-120 kV: JEM 1230; Tecnai T12

W or LaB₆

High contrast & robust
sub-nm resolution

200 kV: JEM 2100F, Tecnai F20, Talos, Artica

FEG

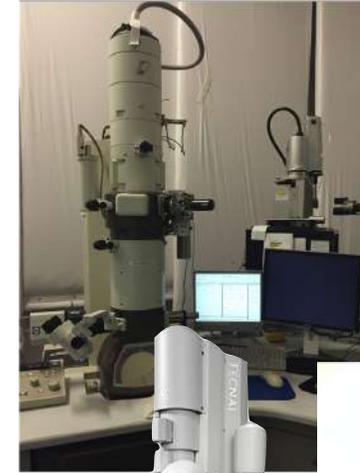
2+ Å resolution (3.5-4 Å)

300 kV: JEM 3200FSC, cryo-ARM, Krios, Polara

FEG

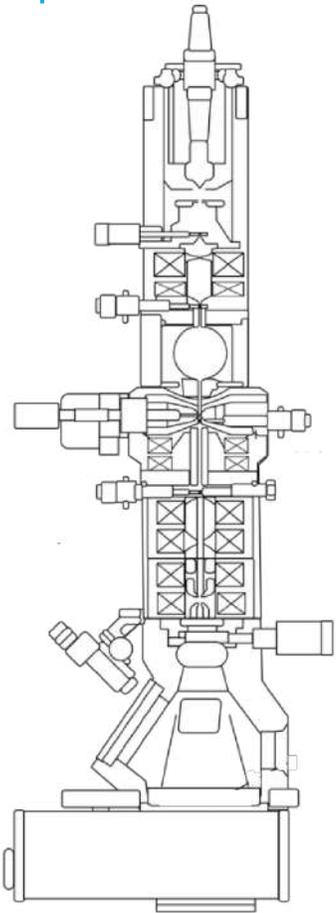
Smaller effect on unwanted lens aberration

1.5-3 Å resolution





ELECTRON SOURCES & TYPES OF EMS

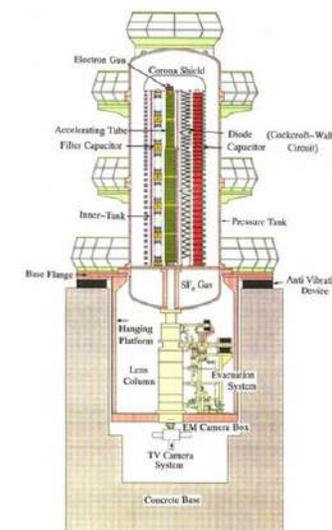


1-1.2 MV: Hitachi, JEOL
LaB6



uhvem.osaka-u.ac.jp

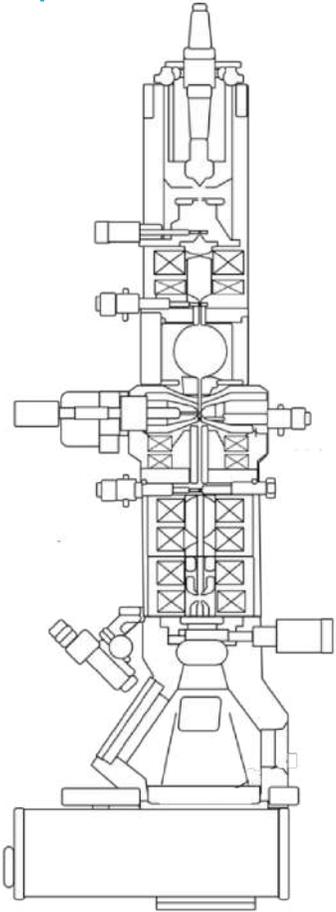
3 MV: Hitachi H3000
LaB6





VACUUM SYSTEMS

Why do we need a vacuum?



Beam coherence - at STP mean free path ~ 1 cm

Insulation - interaction between e- and air

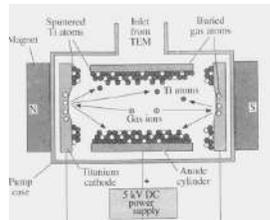
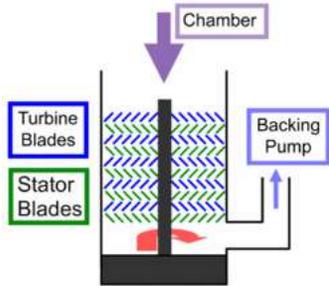
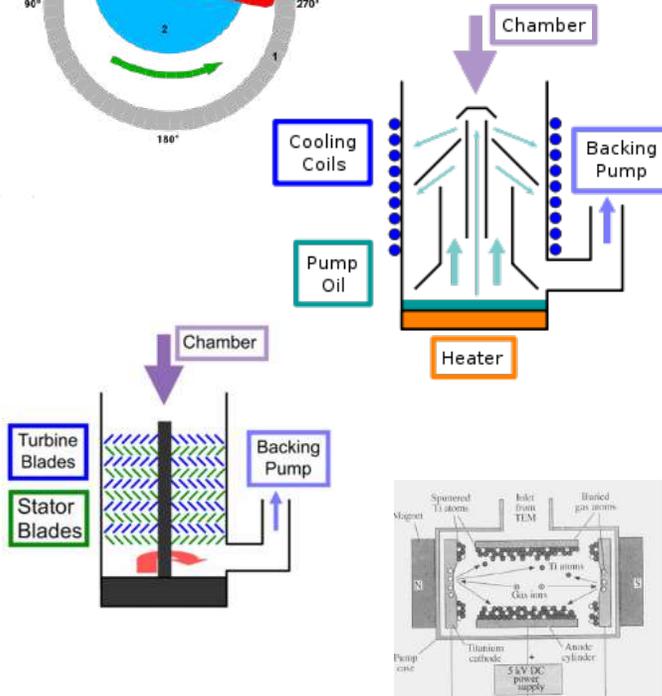
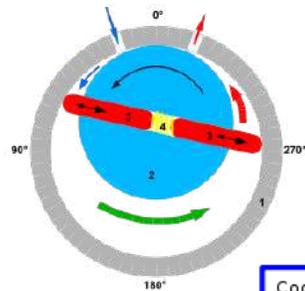
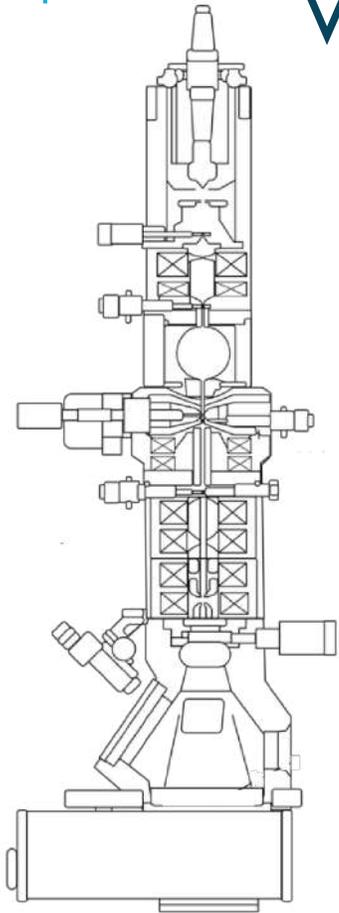
Filament - O₂ will burn out source

Contamination - reduce interaction gas, e-beam and sample



VACUUM SYSTEMS

What types of pumps do we have?



wikipedia.com

1 mm Hg = 1 Torr = 10^2 Pa
1 atm = 760 Torr = 7.5×10^4 Pa

PVP / Rotary 1- 10^{-3} Torr | >0.1 Pa

Diffusion 10^{-3} - 10^{-6} Torr | 0.1 - 10^{-4} Pa

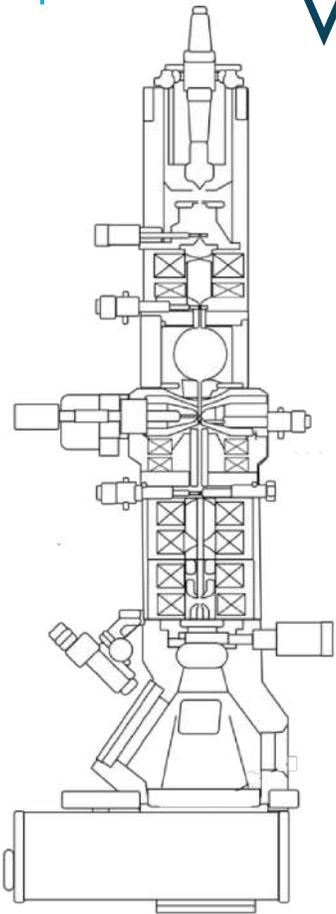
Turbo 10^{-6} - 10^{-9} Torr | 10^{-4} - 10^{-7} Pa

IGP 10^{-9} - 10^{-12} Torr | 10^{-7} - 10^{-9} Pa



VACUUM SYSTEMS

What types of pumps do we have?



Gun

10^{-9} Torr

1 mm Hg = 1 Torr = 10^2 Pa
1 atm = 760 Torr = 7.5×10^4 Pa

Specimen

10^{-6} - 10^{-7} Torr

Chamber and Camera

10^{-5} - 10^{-6} Torr

Vacuum (Supervisor) Control

Status: COL. VALVES

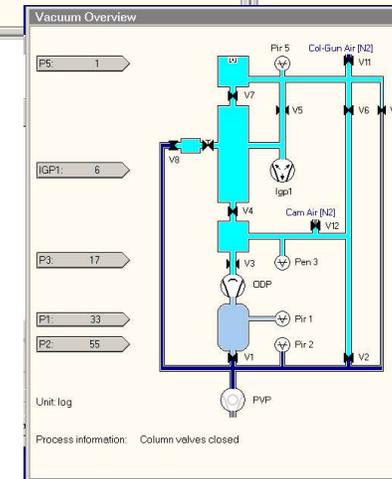
Pressure

Gun/Col	6	Log
Camera	17	Log
Buffertank	33	Log
Backing line	55	Log

Col. Valves Closed

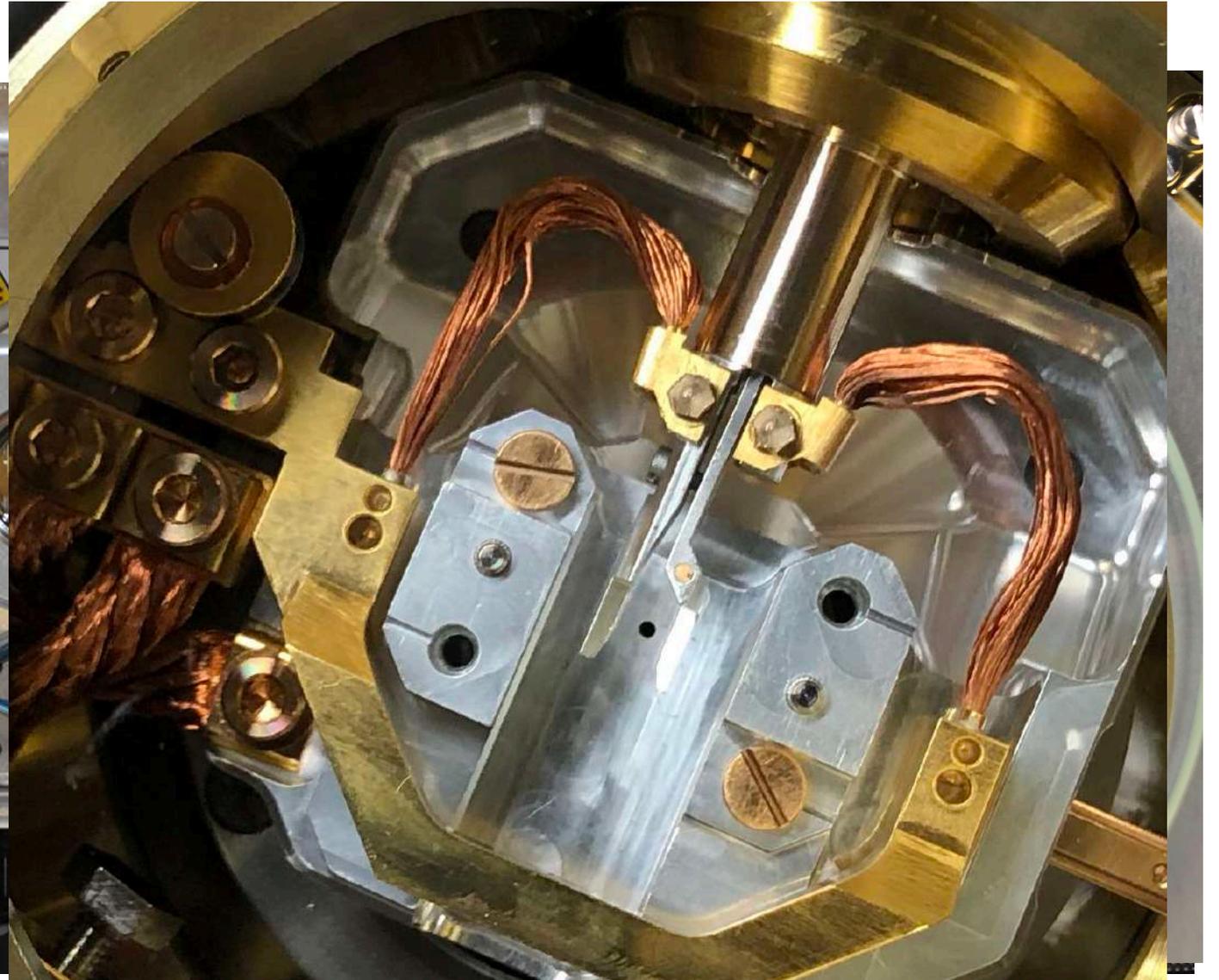
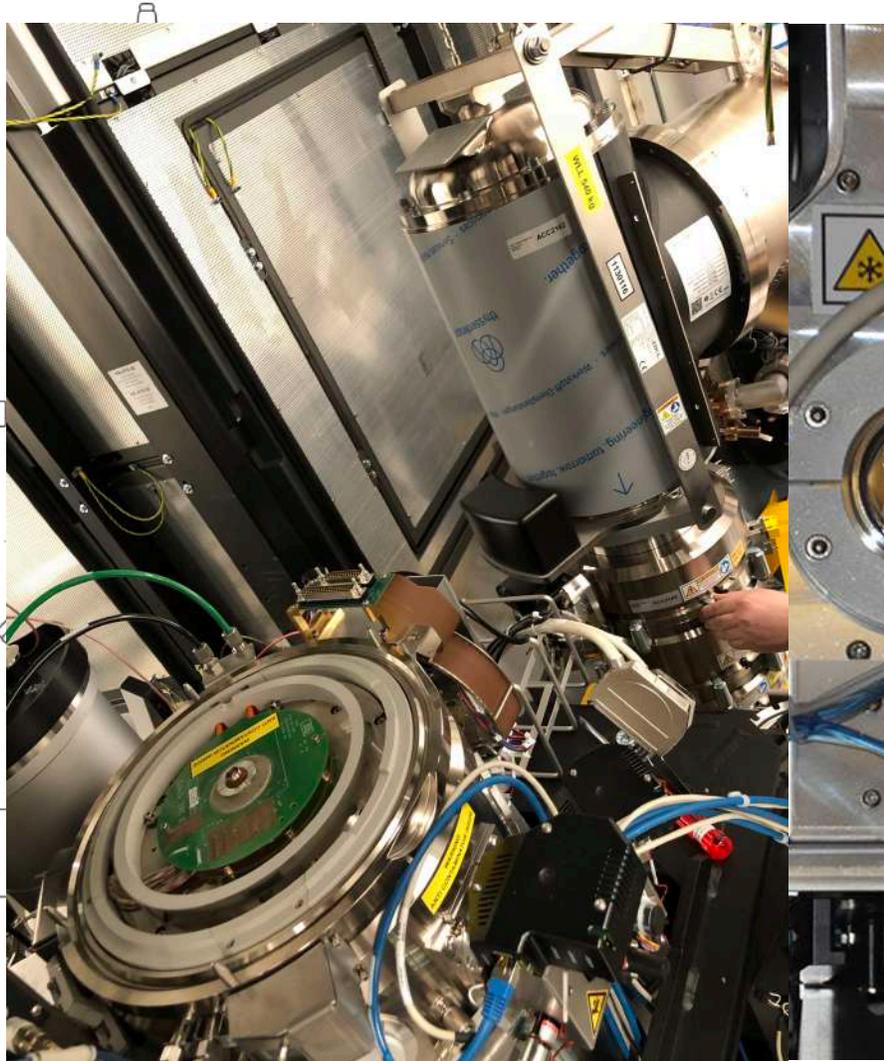
Default pressure unit: Log
Default airlock time: 120 s

Pressure	Torr	Pascal	Log
Gun/Col	88.29 e-9	11.77 e-6	6
Camera	0.35 e-6	46.05 e-6	17
Buffertank	0.19	25.85	33
Backing	3.86	514.32	55





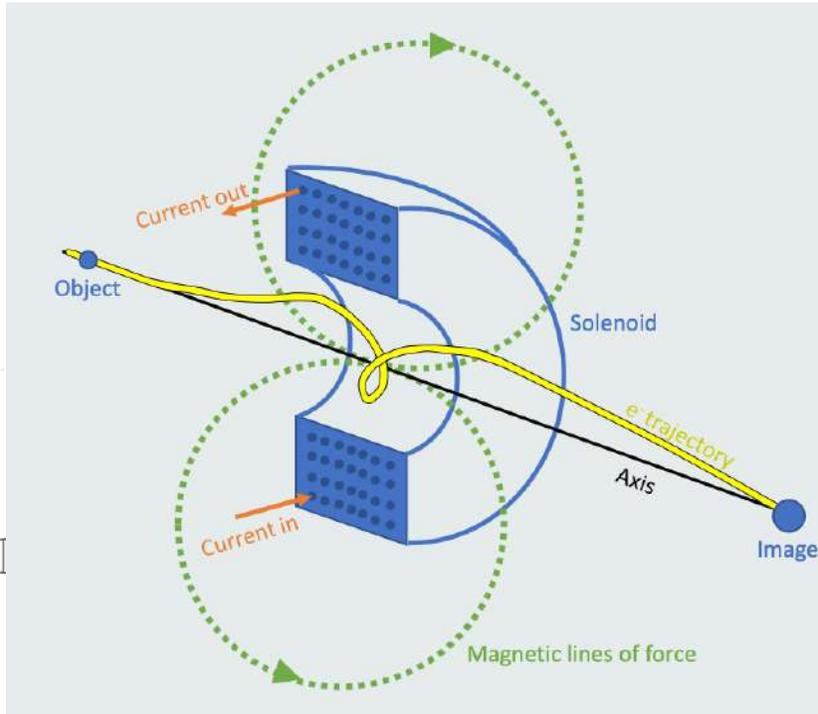
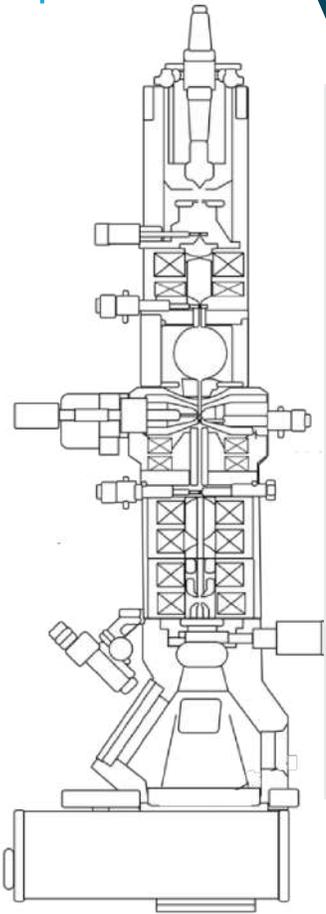
VACUUM SYSTEMS





LENSES

What types of lenses do we have?



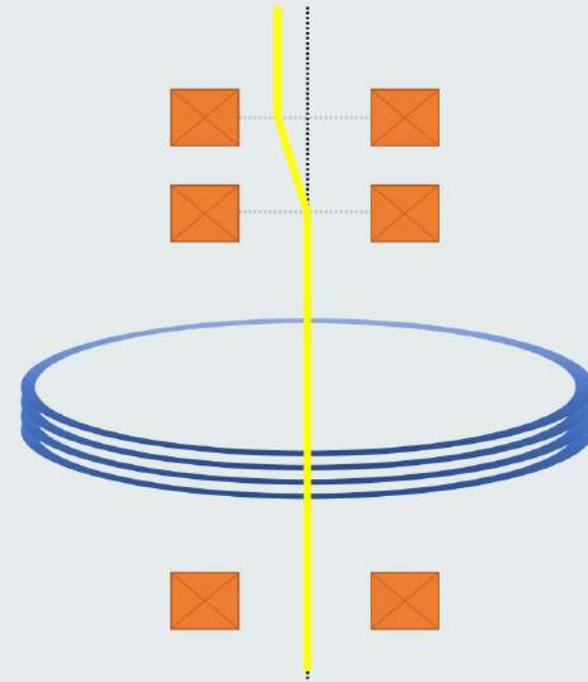
- Focus
- Magnify
- Rotate

Deflector 1 (shift)

Deflector 2 (tilt)

Lens

Stigmator





LENSES

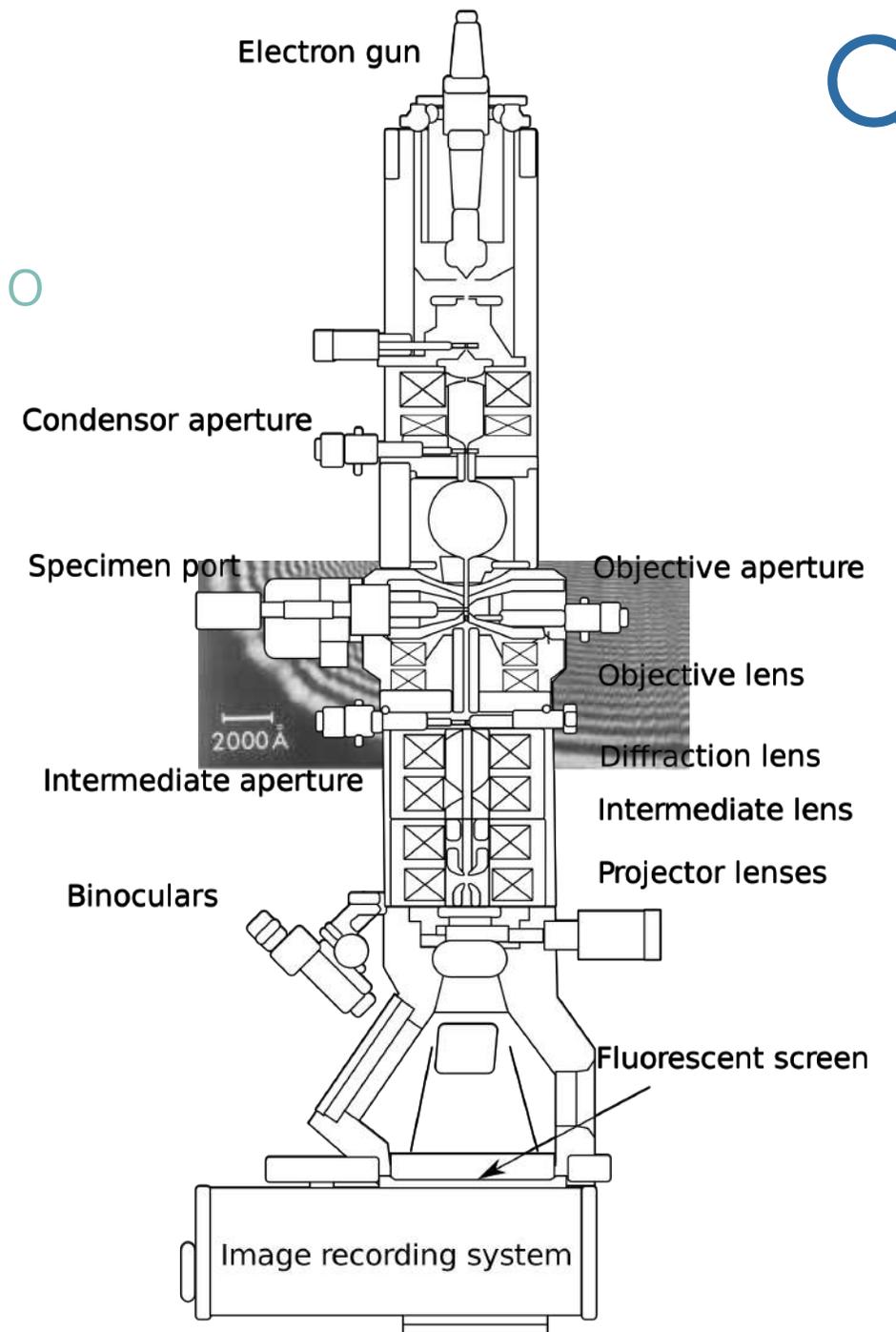
Microscope Alignments What to do & what not to do

Do:

- Start at eucentric height and focus
- Check if it is already good before attempt
- Align from top to bottom

Not to do:

- ~~Align without a way to undo~~
- ~~Align when TEM is not stable (i.e., temperature)~~



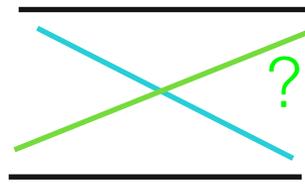


DETECTORS

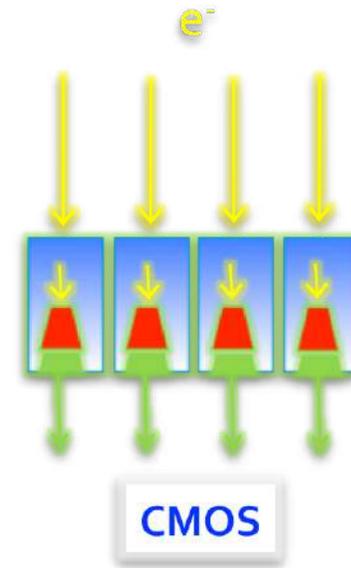
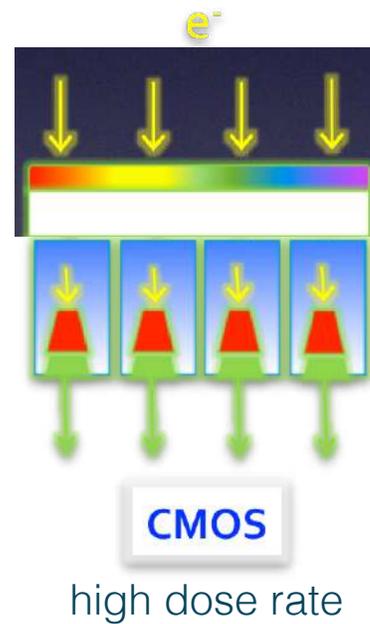
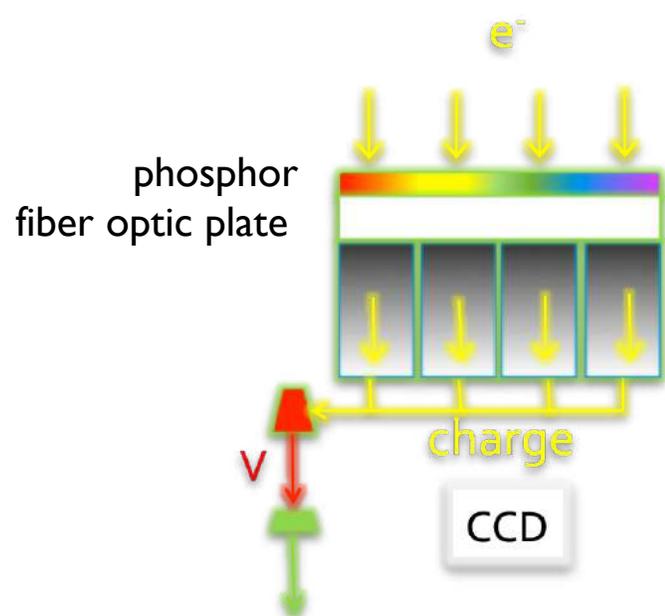
Digital Cameras for TEM

Photon converted

Direct sensing



- **CCD** Charge Coupled Device
- **CMOS** Complementary Metal Oxide Semiconductor



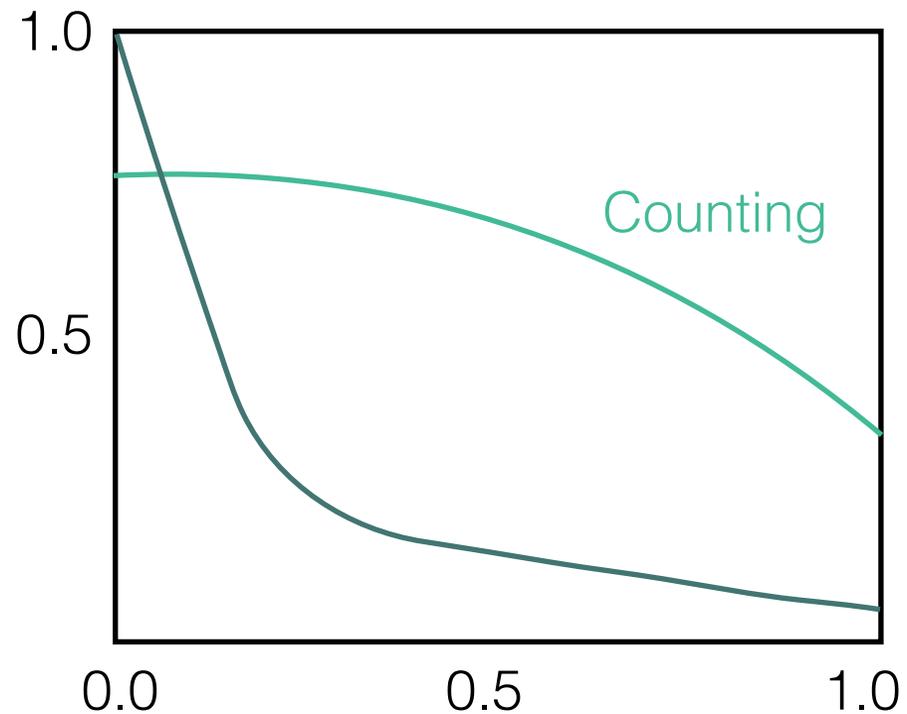
Direct Detectors



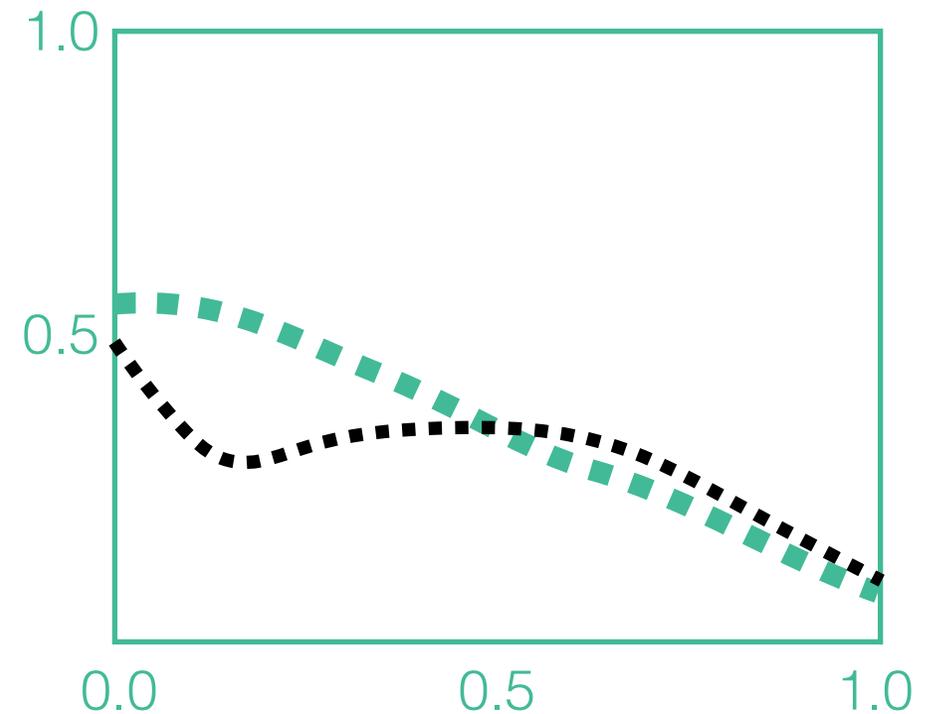
DETECTORS

Detector Performance Characterization

MTF (Modulation Transfer Transform)
contribute to signal envelope



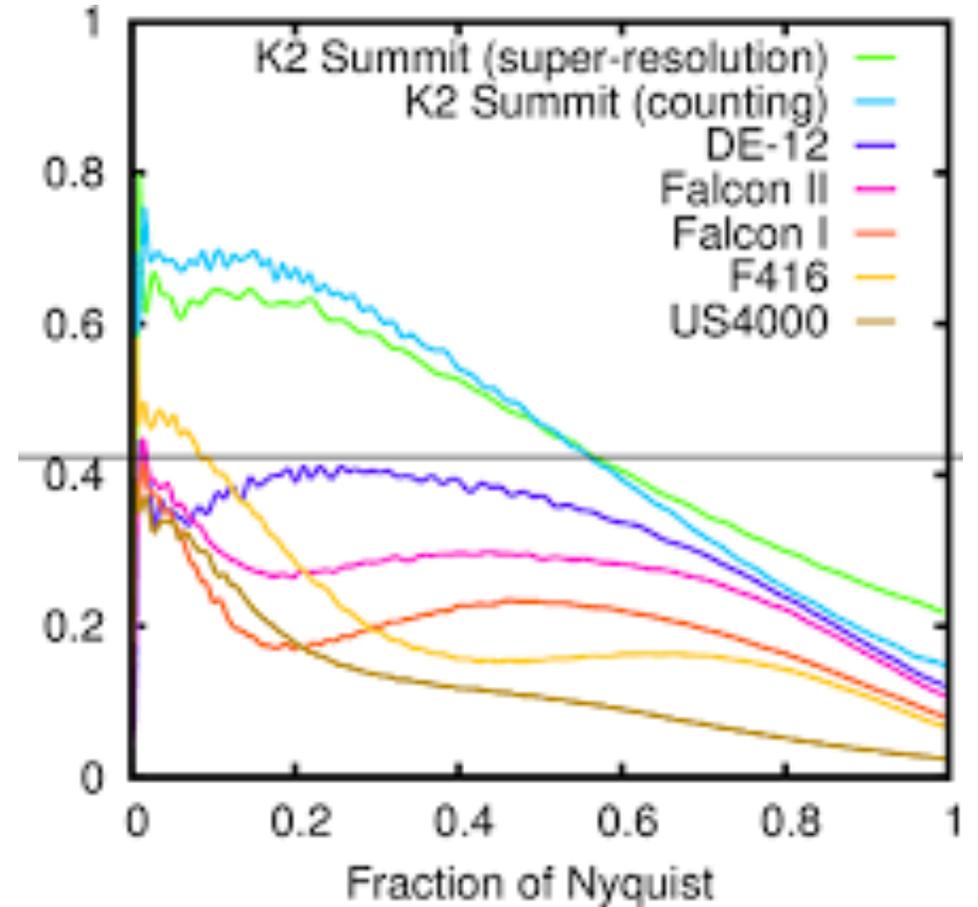
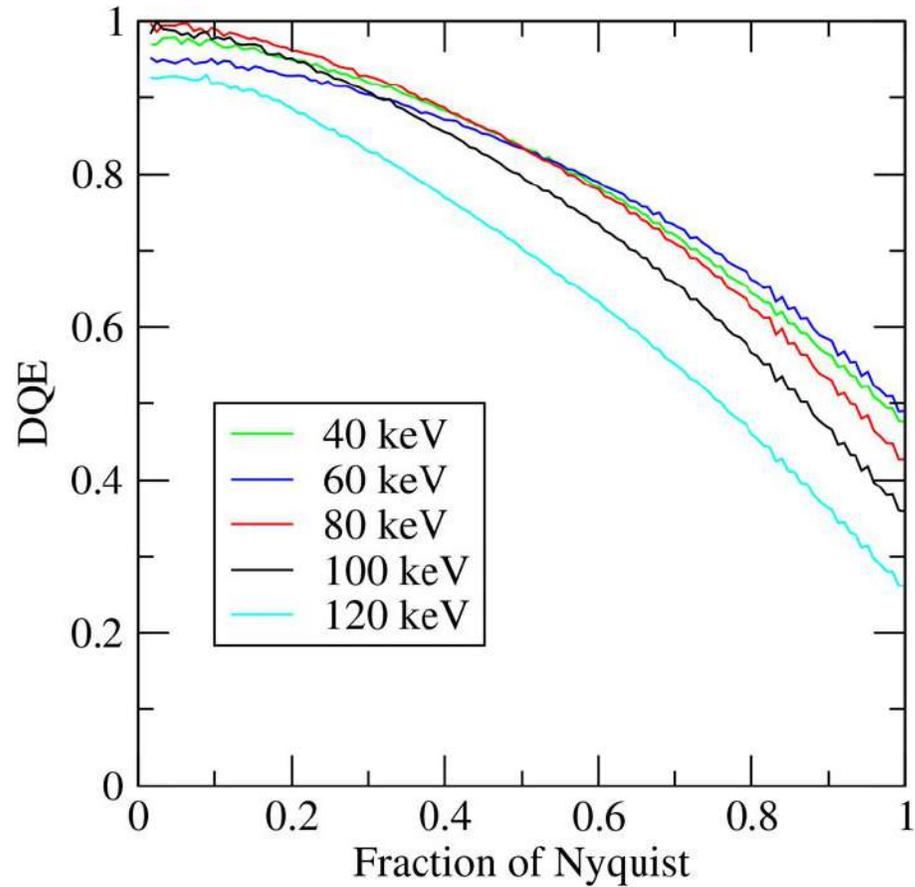
DQE (Detector Quantum Efficiency)
S/N over spatial frequency range





DETECTORS

Detector Performance Characterization





NIH P41 - National Biomedical Technology Research Resources (BTRR)



Krios1

Krios2

Krios3



Krios4

Krios5

Krios6

Krios7



Tecnai F20 Tecnai12

JEOL1230 Helios650



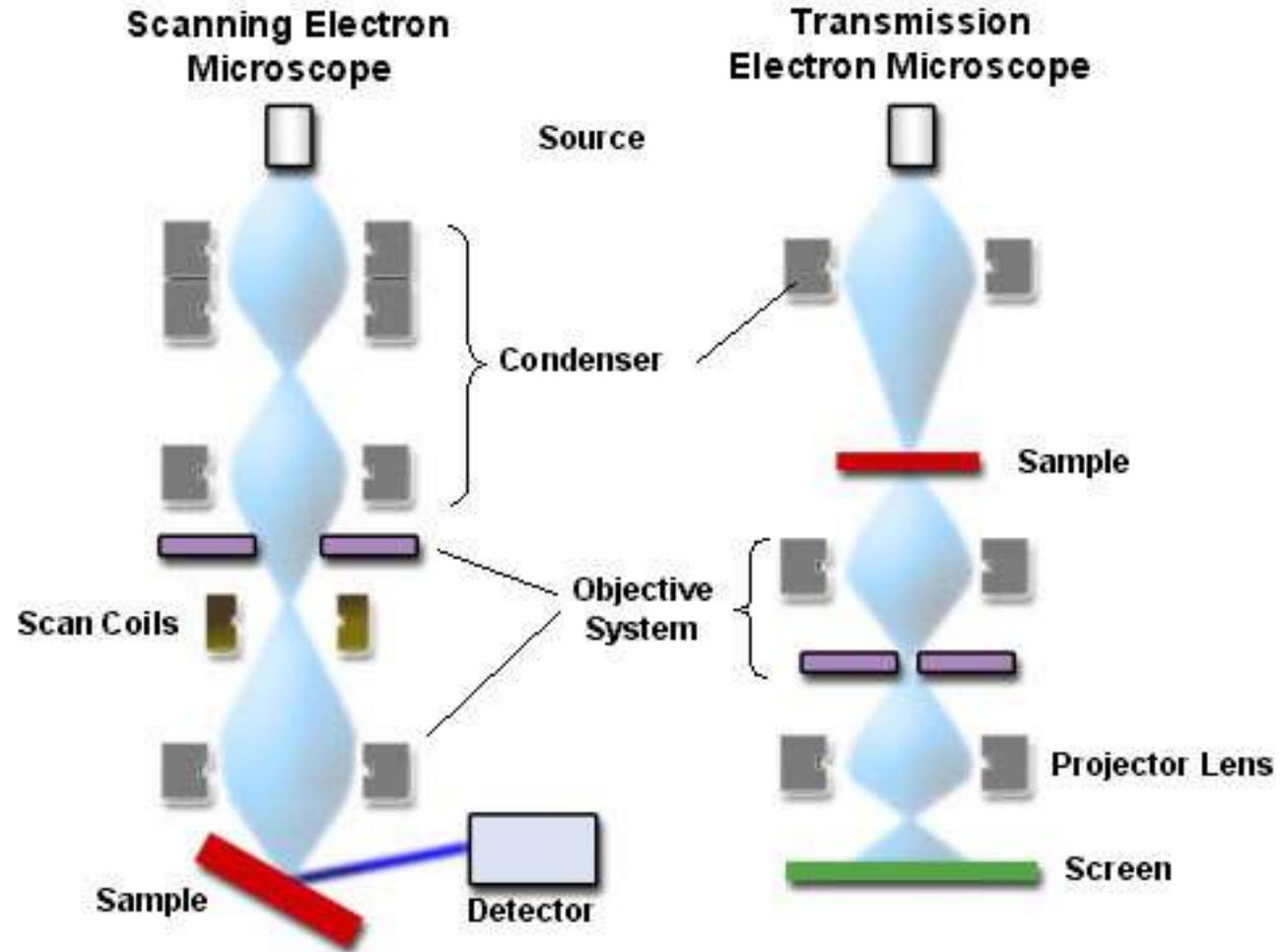
Hitachi 7800

Glacios

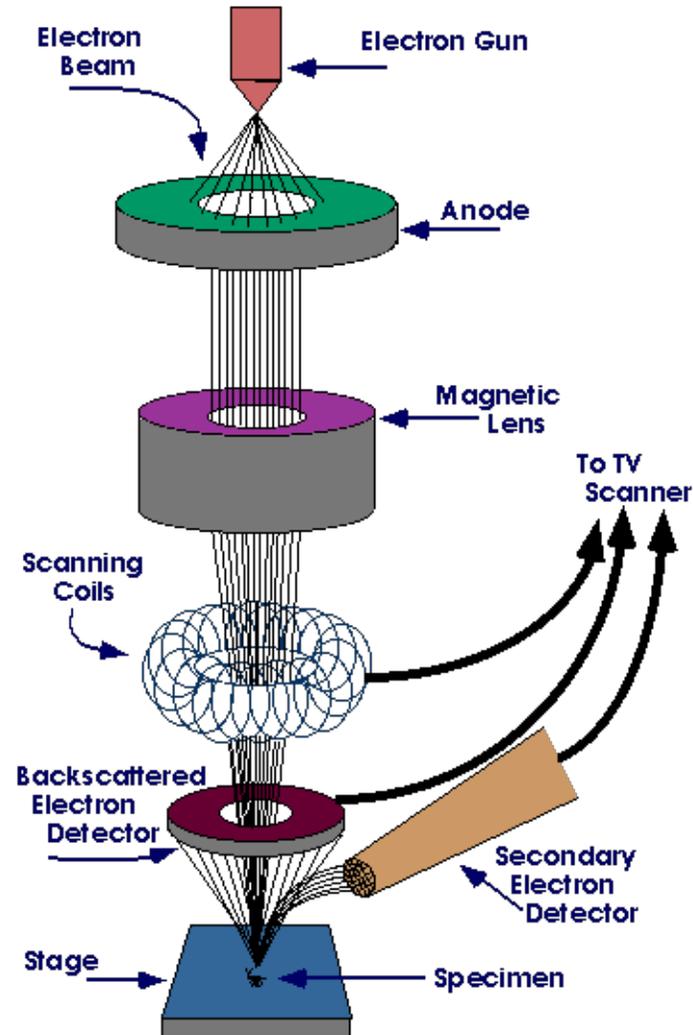


Chameleon

ANATOMY OF AN SEM



ANATOMY OF AN SEM



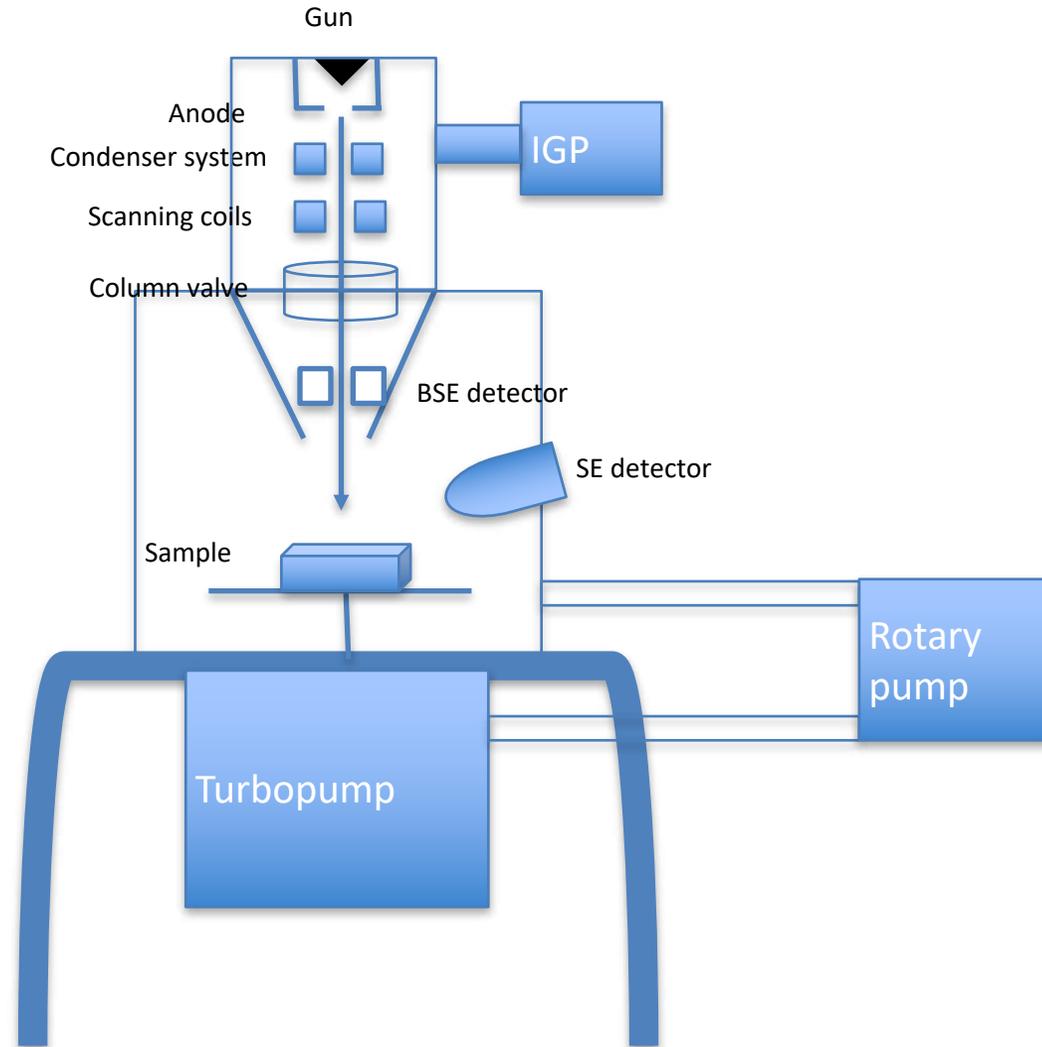
Electron gun: range from tungsten filaments in lower vacuum SEMs to FEGs which need modern high vacuum SEMs

Beam energy: 0.2 – 40 keV is focused by a condenser lens system into a spot of 0.4 – 5 nm

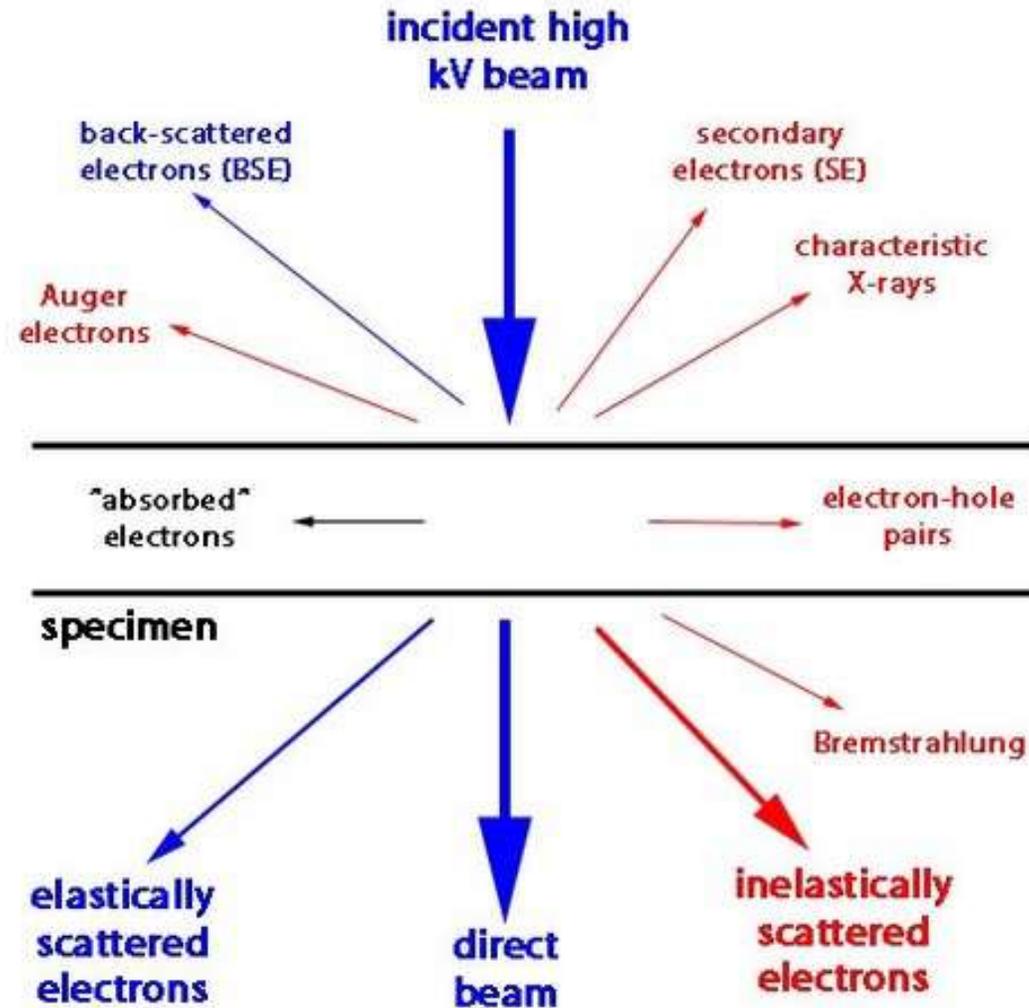
Beam is deflected by very fast scanning coils and rasters the sample surface

Typical resolution of SEM is between 1 and 20 nm where the record is 0.4 nm

ANATOMY OF AN SEM — VACUUM SYSTEMS

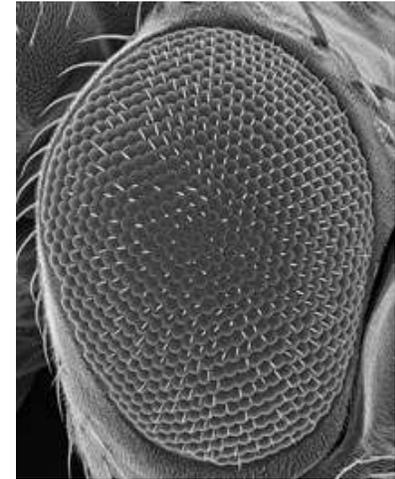
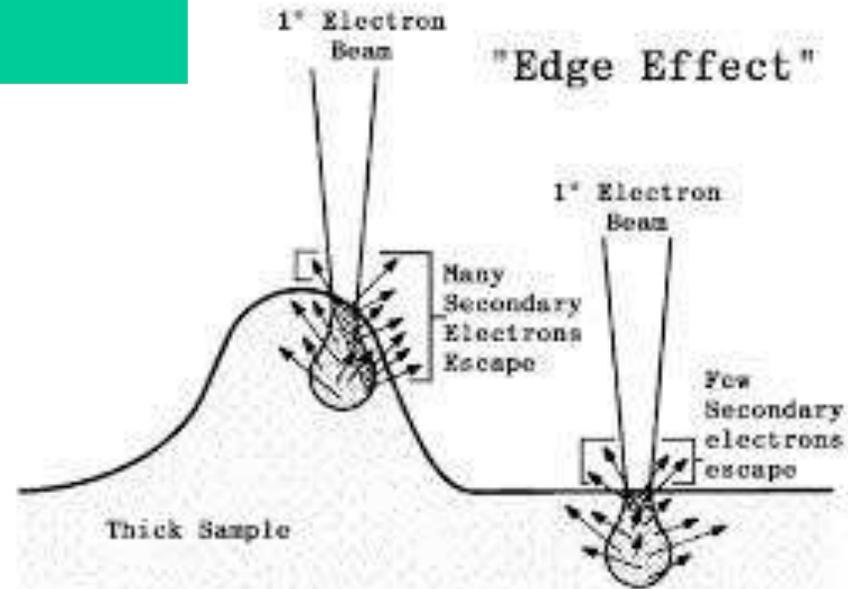
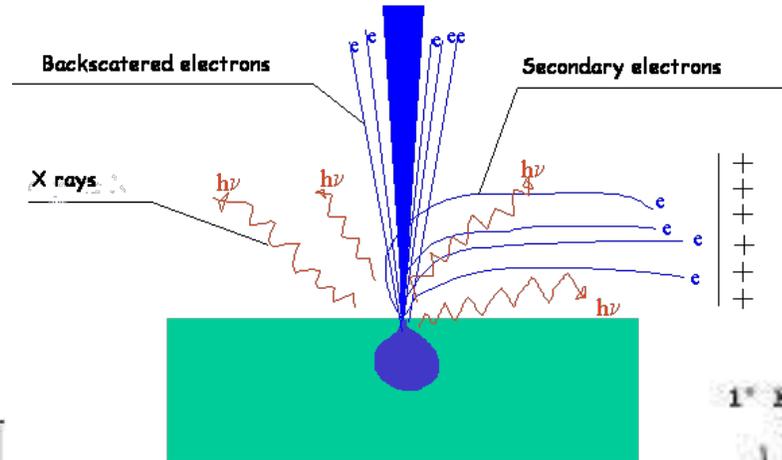
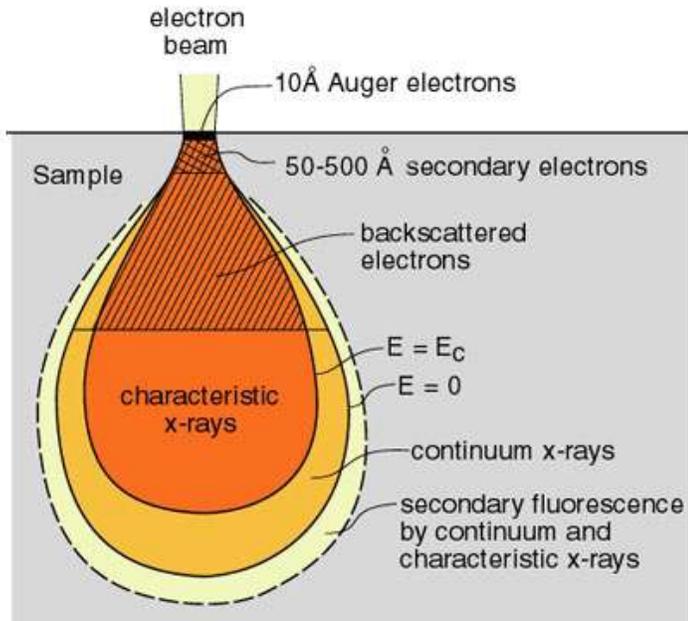


ANATOMY OF AN SEM — BEAM SAMPLE INTERACTIONS

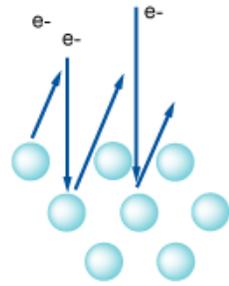


modified from Williams & Carter (1996) Fig. 1.3

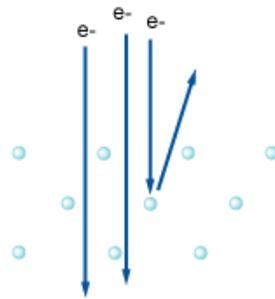
ANATOMY OF AN SEM — BEAM SAMPLE INTERACTIONS & IMAGE FORMATION



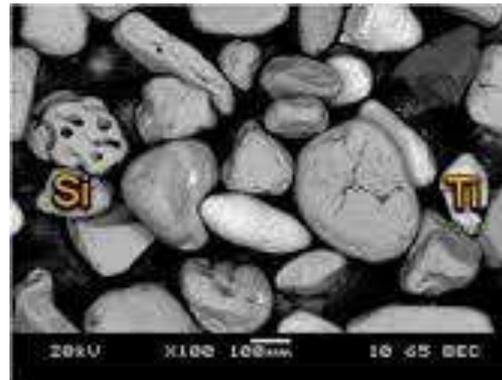
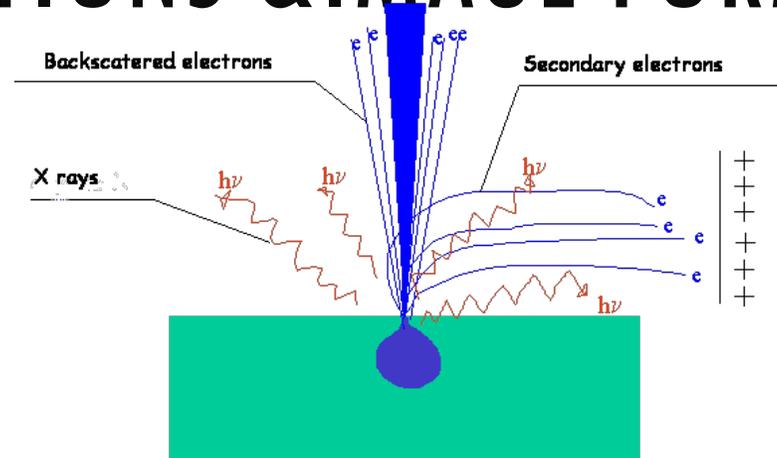
ANATOMY OF AN SEM — BEAM SAMPLE INTERACTIONS & IMAGE FORMATION



Titanium
atomic number 22



Silicon
atomic number 14





TOOLS OF THE TRADE: MICROSCOPES AND DETECTORS

Questions?



cryoEM 001 : Single Particle Masterclass

1. Building a cryoEM toolkit
2. EM compatible samples
3. EM support films and grids
4. Sample preparation
5. Tools of the trade:
microscopes and detectors
6. Microscope operations
7. Data collection strategies
8. Data assessment & QC
9. Data processing:
 - cryoEM IT infrastructure
 - On-the-fly feedback
 - 3D Reconstruction
10. Visualization and validation

ADDITIONAL BACKGROUND READING

Ultramicroscopy 21 (1988) 279–292
North-Holland Amsterdam

279



CONTRAST TRANSFER FOR FROZEN-HYDRATED SPECIMENS: DETERMINATION FROM PAIRS OF DEFOCUS IMAGES

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and

Nigel UNWIN

Medical Research Council Laboratory of Molecular Biology, Hills Road, Cambridge CB2 2QH, UK

Received 15 January 1988; received in revised form 30 March 1988

Electron imaging of frozen-hydrated biological molecules allows atomic maps to be obtained directly, without the need for reconstruction. The appearance of such maps may, however, be strongly influenced by the contrast transfer properties which have not previously been evaluated by quantitative experiments. Here we describe the calculation of the amplitude transfer function in a typical $\lambda = 0.025$ Å (high) freeze specimen, consisting of arrays of ice-crystalline regions, by comparing pairs of images recorded with different defoci. We find that the specimen is imaged as a weak-phase object, and that the contrast transfer function is approximately

1. Introduction

It is now well established that the linear theory of image formation provides a good approximation in accounting for the contrast present in electron micrographs of thin biological specimens (see ref. [1] for a recent review). In this approximation the phase contrast produced by defocusing excites the components of the object having different spacings as $\sin(\chi)$ (if χ is the phase shift of the scattered wave and v is the spatial frequency; see section 2) causing them to be recorded with different weights [2]. Thus there is a direct relation between the object and the image, and it is possible to compensate computationally for the variation in $\sin(\chi)$ (i.e. the phase contrast transfer function) to derive a more accurate representation of the densities composing the specimen [3,4].

* Present address: Medical Research Council Laboratory of Molecular Biology, Hills Road, Cambridge CB2 2QH, UK.
0164-3991/88/0031-0000 © Elsevier Science Publishers B.V. (North-Holland Physics Publishing Division)



Ultramicroscopy 81 (2000) 83–98

ultramicroscopy

www.elsevier.com/locate/ultra

Correction of high-resolution data for curvature of the Ewald sphere

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W.M. Keck Institute for Cellular Visualization, Rosentiel Basic Medical Sciences Research Center, Brandeis University, 40029, 415 South Street, Waltham, MA 02454, USA

Received 6 April 1999; received in revised form 25 August 1999

Abstract

At sufficiently high resolution, which depends on the wavelength of the electrons, the thickness of the sample exceeds the depth of field of the microscope. At this resolution, pairs of beams scattered at symmetric angles about the incident beam are no longer related by Friedel's law; that is, the Fourier coefficients that describe their amplitudes and phases are no longer complex conjugates of each other. Under these conditions, the Fourier coefficients extracted from the image are linear combinations of independent (as opposed to Friedel related) Fourier coefficients corresponding to the three-dimensional (3-D) structure. In order to regenerate the 3-D scattering density, the Fourier coefficients corresponding to the structure have to be recovered from the Fourier coefficients of each image. The requirement for different views of the structure in order to collect a full 3-D data set remains. Computer simulations are used to determine at what resolution, voltage and specimen thickness the extracted coefficients differ significantly from the Fourier coefficients needed for the 3-D structure. This paper presents the theory that describes this situation. It reminds us that the problem can be treated by considering the curvature of the Ewald sphere or equivalently by considering that different layers within the structure are imaged with different amounts of defocus. The paper presents several methods to extract the Fourier coefficients needed for a 3-D reconstruction. The simplest of the methods is to take images with different amounts of defocus. For helical structures, however, only one image is needed. © 2000 Elsevier Science B.V. All rights reserved.

Keywords: Electron microscopy; Depth of field

1. Introduction

The assumption in three-dimensional (3-D) image reconstruction is that the image is a projection of the 3-D structure [1]. This assumption breaks down if the object does not obey the weak phase object approximation or if size of the specimen exceeds the depth of field of the microscope. This paper considers the latter problem only. The assumption that the image is a projection breaks down at sufficiently high resolution [2] at which resolution the thickness of the specimen exceeds the depth of field of the microscope.

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E-mail address: derosier@brandeis.edu (D.J. DeRosier)

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Ewald sphere correction for single-particle electron microscopy

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Abstract

Most algorithms for three-dimensional (3D) reconstruction from electron micrographs assume that images correspond to projections of the 3D structure. This approximation limits the attainable resolution of the reconstruction when the dimensions of the structure exceed the depth of field of the microscope. We have developed two methods to calculate a reconstruction that corrects for the depth of field. Either method applied to synthetic data representing a large virus yields a higher resolution reconstruction than a method lacking this correction.

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1. Introduction

The three-dimensional (3D) reconstruction of a biological molecule or complex from images of single, isolated particles is an important step in electron microscopy (EM) of macromolecules. The reconstruction algorithms commonly used assume that the images are projections of the three-dimensional (3D) object. Although this assumption is a valid approximation for many situations, it breaks down when the size of the object and the desired resolution exceed the depth of field of the microscope [1]. The present work describes two methods to accommodate the depth of field in the reconstruction and alignment of single particles without the use of tilt or defocus pairs. We demonstrate the validity of the approach using simulations.

2. Theory

2.1. Ewald construction

A 3D reconstruction algorithm can be understood most easily by considering its action in reciprocal space. The

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Estimating the effect of finite depth of field in single-particle cryo-EM

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ABSTRACT

The extent to which the resolution varies within a three-dimensional (3-D) reconstruction, when the diameter of an object is large, is investigated computationally. Numerical simulation is used to model ideal three-dimensional point-spread functions at different radial positions within an object. It is shown that reconstructed density maps are affected less than might have been expected when particles are larger than the depth of field. This favorable outcome is attributed mainly to the fact that a point which lies outside the depth of field relative to the center, for some orientations of the object, will also lie within the depth of field for other orientations. We find, as a result, that the diameter of a particle can be as much as four times the depth of field (as defined by a 90° phase-error criterion) before curvature of the Ewald sphere becomes a limiting factor in determining the resolution that can be achieved.

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1. Introduction

High-resolution electron microscopy of unstained biological macromolecules (single-particle cryo-EM for short) has recently made significant advances [14]. Three-dimensional density maps of large macromolecules are now being obtained with a resolution in the range from 3 to 4 Å, and in a few cases the resolution has also exceeded 2.5 Å [3,4,13]. A fundamental approximation used in this method is that the image intensity is linear in the projected Coulomb potential of the specimen – see, for example, Chapter 4 of [7]. Equivalently, when referring to Fourier space rather than real space, the corresponding approximation is that curvature of the Ewald sphere [6] can be neglected.

Validity of the assumed “projection” approximation requires, among other things, that all portions of the specimen are imaged with the same amount of defocus. This only happens, of course, if the size of the object (i.e. its thickness) is much less than the optical depth of field. As a result, the fundamental approximation, i.e. that the image is a projection of the object, is not expected to be useful if the size of the object is similar to, or much greater than, the depth of field.

This issue has been raised in the past, both in the context of very large virus particles [10,17] and in the context of smaller particles that are randomly distributed within a certain range of Z-heights, which is determined by the overall ice thickness [9]. It seemed to be paradoxical, for example, that high-resolution, three-dimensional reconstructions were obtained from images of icosahedral virus particles whose diameters are larger than the corresponding depth of field [8,12,16]. An often-mentioned resolution of this paradox is that a large number of (symmetry-related) subunits are located at the same Z-height as is the middle of the virus particle. At the same time, it is suggested – reasonably so – that estimation of the defocus value for the image of a virus particle is biased towards the middle, i.e. its center of mass. Thus, if the contrast-transfer-function (CTF) correction for the region near to the middle of a large virus particle is done correctly, a significant amount of signal may be produced from the many subunits whose images have been properly corrected. The suggestion is that this signal can overwhelm the (high-resolution) “noise” contributed by other subunits that lie at Z-heights that are outside the depth of field. Because of this argument, it seemed plausible that the depth of field might be a greater limitation for asymmetric particles than it is for icosahedral virus particles. It thus remains inconclusive that no improvement in the quality of density maps was obtained when computational algorithms were used to compensate for violation of the projection approximation for images of large, icosahedral virus particles [11,15].

We now reopen the question by using computational simulations to better understand what limitations to expect when the size of a particle approaches, and even exceeds, the depth of field for a given resolution. The approach that we have taken is to first calculate noise-free, three-dimensional (3-D) reconstructions of “single points” that are located at different distances from the center of an object. The resulting 3-D point-spread functions are then convoluted with high-resolution density maps for atomic models of two peptide structures found in tubulin, the sizes of which are both much smaller than the depth of field for 300 keV

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